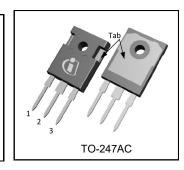


V _{DSS}	60V
R _{DS(on)} typ.	2.75m $Ω$
max	$3.30 m\Omega$
I _D	172A

Gate Pin 1 Source Pin 3



G	D	S
Gate	Drain	Source

Application

- Brushed Motor drive applications
- BLDC Motor drive applications
- · Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free, RoHS Compliant

Raco part number	Dookogo Tymo	Standard Pack		Ordereble Bort Number
Base part number	Package Type	Form Quanti		Orderable Part Number
IRFP7537PbF	TO-247AC	Tube	25	IRFP7537PbF

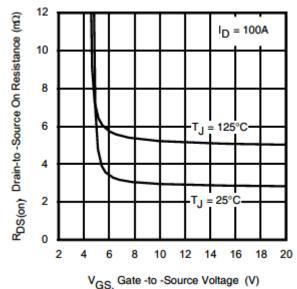


Fig 1. Typical On-Resistance vs. Gate Voltage

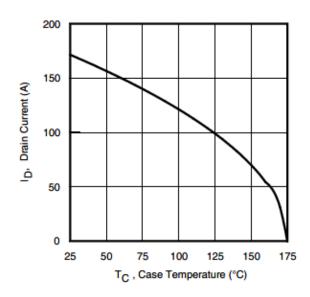


Fig 2. Maximum Drain Current vs. Case Temperature



Absolute Maximum Rating

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	172	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10V	121	Α
I _{DM}	Pulsed Drain Current ①	700	
P _D @T _C = 25°C	Maximum Power Dissipation	230	W
	Linear Derating Factor	1.5	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting Torque, 6-32 or M3 Screw	10 lbf·in (1.1 N·m)	

Avalanche Characteristics

E _{AS} (Thermally limited)	Single Pulse Avalanche Energy ②	250	m l
E _{AS (Thermally limited)}	Single Pulse Avalanche Energy ®	554	mJ
I _{AR}	Avalanche Current ①	Soo Fig 45 46 220 22b	Α
E _{AR}	Repetitive Avalanche Energy ①	See Fig 15, 16, 23a, 23b	mJ

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑦		0.66	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface	0.24		°C/W
$R_{ heta JA}$	Junction-to-Ambient		40	

Static @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		40		mV/°C	Reference to 25°C, I _D = 1mA ①
R _{DS(on)}	Static Drain-to-Source On-Resistance		2.75	3.30	m()	$V_{GS} = 10V, I_D = 100A$
			3.50		mΩ	$V_{GS} = 6.0V, I_D = 50A$
$V_{GS(th)}$	Gate Threshold Voltage	2.1		3.7	V	$V_{DS} = V_{GS}, I_{D} = 150 \mu A$
	Drain-to-Source Leakage Current			1.0		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{V}$
IDSS	Dialii-to-Source Leakage Current			150	μA	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			100	nΛ	V _{GS} = 20V
IGSS	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
R_G	Gate Resistance		2.0		Ω	

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by T_{Jmax} , starting T_J = 25°C, L = 50 μ H, R_G = 50 Ω , I_{AS} = 100A, V_{GS} =10V.
- $\label{eq:local_local_local_local} \ensuremath{\Im} \quad I_{SD} \leq 100A, \ di/dt \leq 1130A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- $^{\circ}$ C_{oss} eff. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- ⑥ C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \mathbb{T} R_{θ} is measured at T_J approximately 90°C.
- \$ Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 1mH, $R_G = 50\Omega$, $I_{AS} = 33A$, $V_{GS} = 10V$.



Dynamic Electrical Characteristics @ $T_J = 25$ °C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	190			S	V _{DS} = 10V, I _D =100A
Q_g	Total Gate Charge		142	210		I _D = 100A
Q_{gs}	Gate-to-Source Charge		36		nC	V _{DS} = 30V
Q_{gd}	Gate-to-Drain Charge		43		IIC	V _{GS} = 10V
Q _{sync}	Total Gate Charge Sync. (Qg- Qgd)		99			
$t_{d(on)}$	Turn-On Delay Time		15			$V_{DD} = 30V$
t _r	Rise Time		105			I _D = 100A
$t_{d(off)}$	Turn-Off Delay Time		82		ns	$R_G = 2.7\Omega$
t _f	Fall Time		84			V _{GS} = 10V4
C _{iss}	Input Capacitance		7020			$V_{GS} = 0V$
Coss	Output Capacitance		640			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		395		pF	f = 1.0MHz, See Fig.7
C _{oss eff.(ER)}	Effective Output Capacitance (Energy Related)		665			V _{GS} = 0V, VDS = 0V to 48V®
Coss eff.(TR)	Output Capacitance (Time Related)		880			V _{GS} = 0V, VDS = 0V to 48V⑤

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			172	l l	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			700		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.2	V	$T_J = 25^{\circ}C, I_S = 100A, V_{GS} = 0V $ ④
dv/dt	Peak Diode Recovery dv/dt③		10		V/ns	$T_J = 175^{\circ}C, I_S = 100A, V_{DS} = 60V$
t _{rr}	Reverse Recovery Time		39 41		ns	$\frac{T_J = 25^{\circ}C}{T_J = 125^{\circ}C}$ $V_{DD} = 51V$ $V_{DD} = 1000$
Q _{rr}	Reverse Recovery Charge		46 56		nC	$T_{\underline{J}} = 25^{\circ}C$ di/dt = 100A/ μ s \oplus $T_{\underline{J}} = 125^{\circ}C$
I _{RRM}	Reverse Recovery Current		2.1		Α	T _J = 25°C



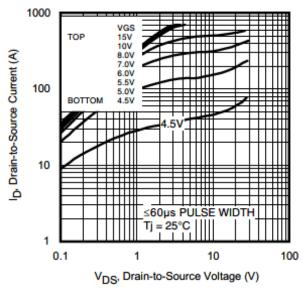


Fig 3. Typical Output Characteristics

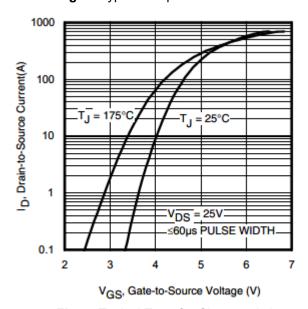


Fig 5. Typical Transfer Characteristics

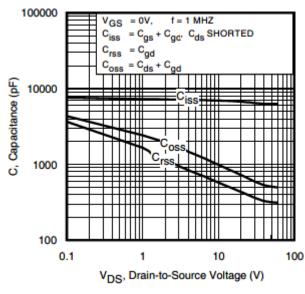


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

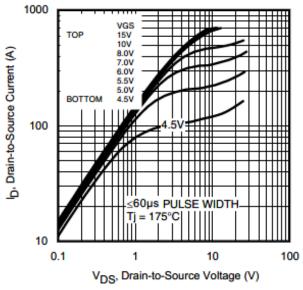


Fig 4. Typical Output Characteristics

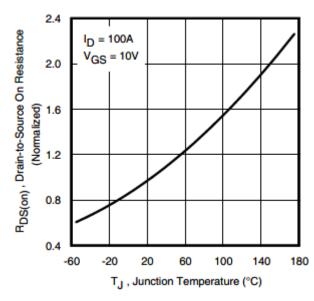


Fig 6. Normalized On-Resistance vs. Temperature

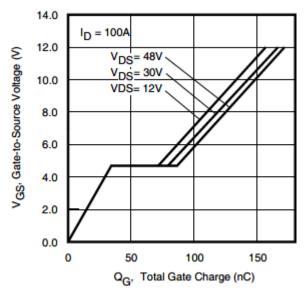


Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage



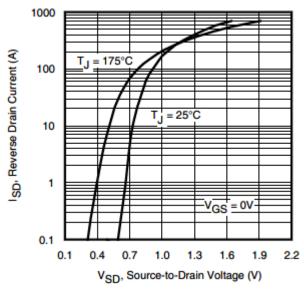


Fig 9. Typical Source-Drain Diode Forward Voltage

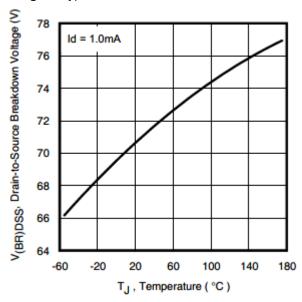


Fig 11. Drain-to-Source Breakdown Voltage

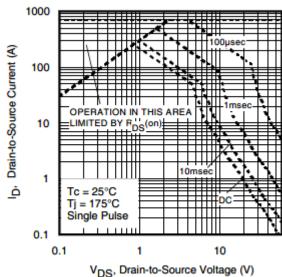


Fig 10. Maximum Safe Operating Area

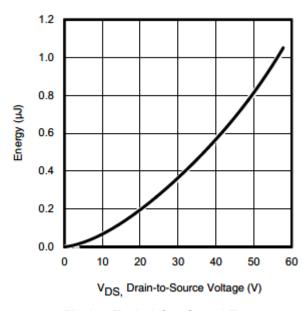


Fig 12. Typical Coss Stored Energy

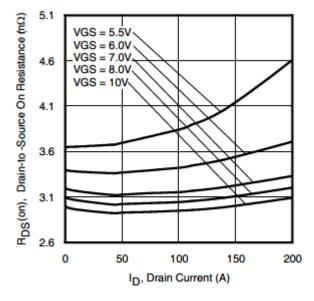


Fig 13. Typical On-Resistance vs. Drain Current



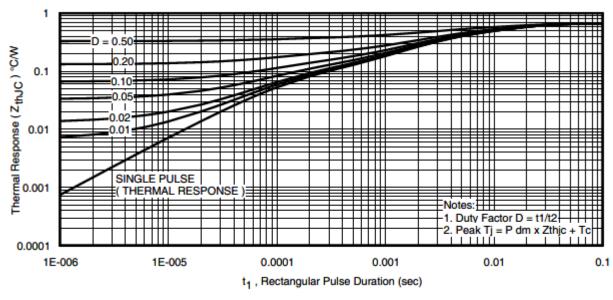


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

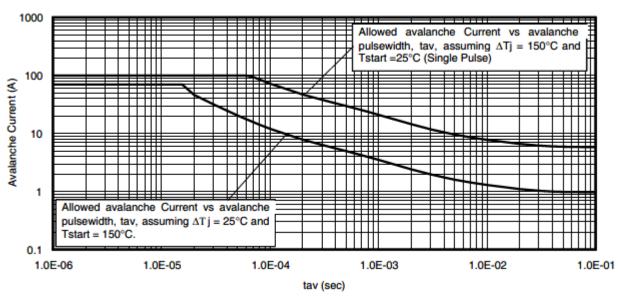


Fig 15. Avalanche Current vs. Pulse Width

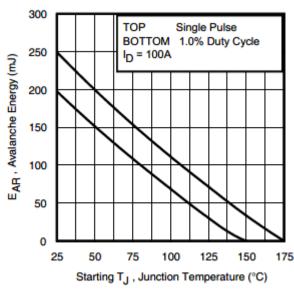


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

1. Avalanche failures assumption:

Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every

- 2. Safe operation in Avalanche is allowed as long as T_{imax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 14, 15). t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 14)

PD (ave) = 1/2 ($1.3 \cdot BV \cdot I_{av}$) = $\Delta T/Z_{thJC}$

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$

 $E_{AS (AR)} = P_{D (ave)} t_{av}$



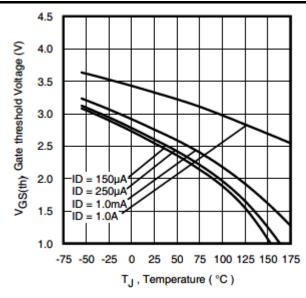


Fig 17. Threshold Voltage vs. Temperature

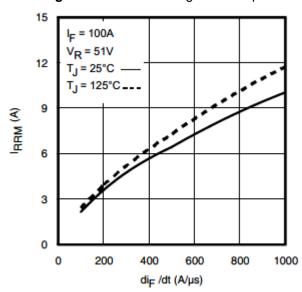


Fig 19. Typical Recovery Current vs. dif/dt

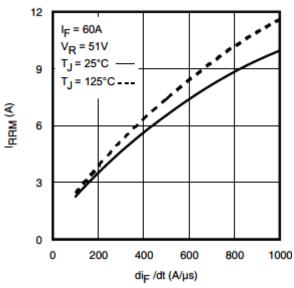


Fig 18. Typical Recovery Current vs. dif/dt

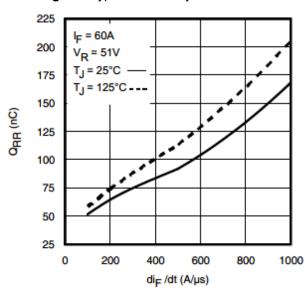


Fig 20. Typical Stored Charge vs. dif/dt

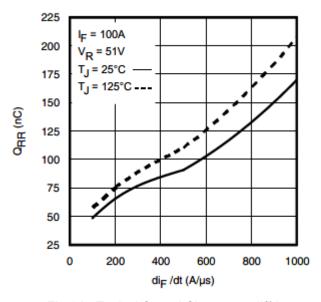


Fig 21. Typical Stored Charge vs. dif/dt



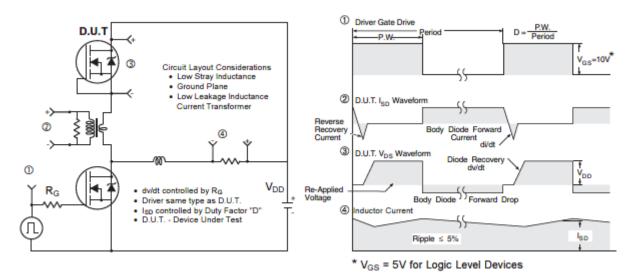


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

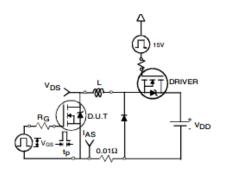


Fig 23a. Unclamped Inductive Test Circuit

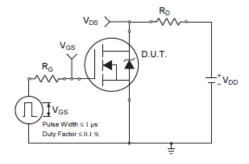


Fig 24a. Switching Time Test Circuit

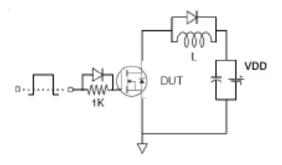


Fig 25a. Gate Charge Test Circuit

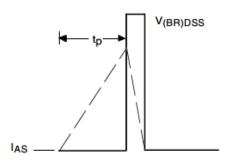


Fig 23b. Unclamped Inductive Waveforms

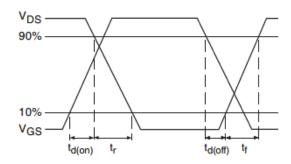


Fig 24b. Switching Time Waveforms

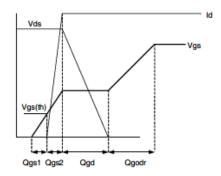
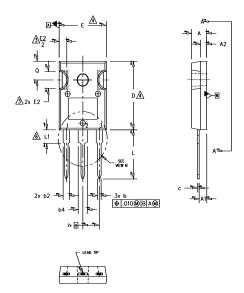
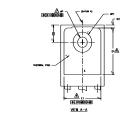


Fig 25b. Gate Charge Waveform



TO-247AC Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
- 2. DIMENSIONS ARE SHOWN IN INCHES.

(3) CONTOUR OF SLOT OPTIONAL.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

5 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

6 LEAD FINISH UNCONTROLLED IN L1.

 $\ensuremath{\text{\textit{P}}}$ to have a maximum draft angle of 1.5 ° to the top of the part with a maximum hole diameter of .154 inch.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC .

		DIMEN	ISIONS		
SYMBOL	INC	HES	MILLIN	IETERS	
	MIN.	MAX.	MIN.	MAX.	NOTES
A	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
ь1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.133	2.59	3.38	
С	.015	.035	0.38	0.89	
c1	.015	.033	0.38	0.84	
D	.776	.815	19.71	20.70	4
D1	.515	-	13.08	-	5
D2	.020	.053	0.51	1.35	
E	.602	.625	15.29	15.87	4
E1	.530	-	13.46	-	
E2	.178	.216	4.52	5.49	
е	.215	BSC	5.46	BSC	1
Øk	.0	10	0.	25	
L	.559	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
øΡ	.140	.144	3.56	3.66	
øP1	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217	BSC	5.51	BSC	
I	ı		11		ı

LEAD ASSIGNMENTS

<u>HEXFET</u>

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

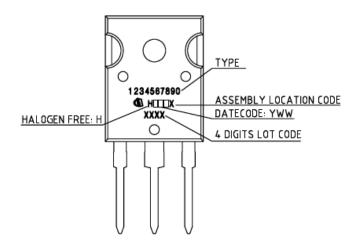
IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR
- 4.- COLLE

<u>DIODES</u>

- 1.- ANODE/OPEN
- 2.- CATHODE 3.- ANODE

TO-247AC Part Marking Information



TO-247AC package is not recommended for Surface Mount Application.



Qualification Information[†]

Qualification Level	Industrial (per JEDEC JESD47F) ††			
Moisture Sensitivity Level	TO-247 N/A			
RoHS Compliant	Yes			

- † Qualification standards can be found at Infineon web site: https://www.infineon.com/
- †† Applicable version of JEDEC standard at the time of product release.

Revision History

Date	Rev.	Comments
2014-11-18	2.1	 Updated E_{AS} (L =1mH) = 554mJ on page 2 Updated note 8 "Limited by T_{Jmax}, starting T_J = 25°C, L = 1mH, R_G = 50Ω, I_{AS} = 33A, V_{GS} =10V". on page 2
2024-10-03	2.2	 Update datasheet to Infineon format Updated Part marking –page 9 Added disclaimer on last page.



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